

MASSACHUSETTS INSTITUTE OF TECHNOLOGY  
Department of Electrical Engineering and Computer Science

6.012 MICROELECTRONIC DEVICES AND CIRCUITS

Problem Set No. 3

**Issued:** September 23, 2009

**Due:** September 30, 2009

**Reading Assignments:**

Lecture 5 (9/24/09) - Chap. 5 (5.1)

Lecture 6 (9/29/09) - Chap. 7 (7.3)

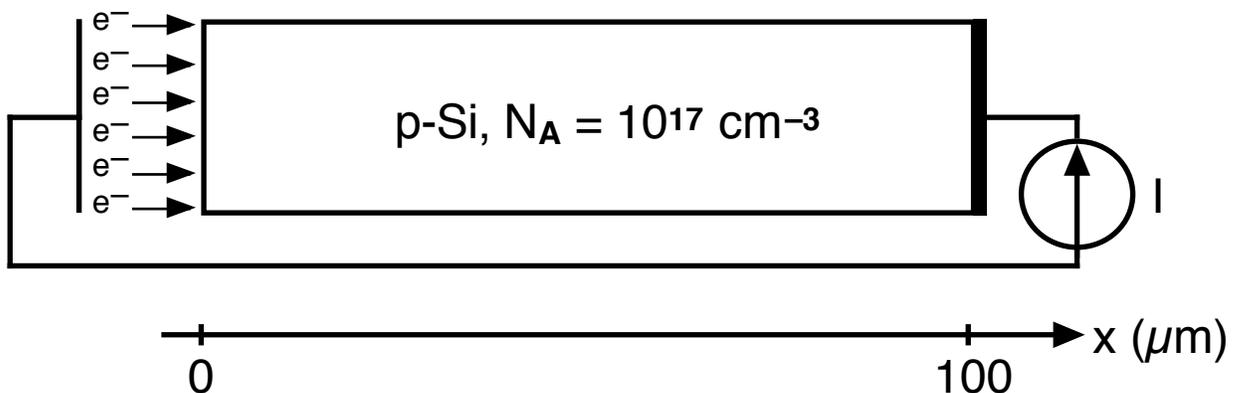
Lecture 7 (10/1/09) - Chap. 8 (8.1)

**Note:** The first hour exam is scheduled for Wednesday night, October 7, from 7:30 to 9:30 pm Please let me know as soon as possible (by e-mail) if you have a conflict so we can resolve it as painlessly as possible. The exam is closed book and will cover the material through 10/2/09 and Problem Set #4 (p-n junction diodes and BJT basics).

**Problem 1** - Do Problem 7.3 in the course text.

**Problem 2** - This problem concerns a bar of p-type silicon,  $N_A = 10^{17} \text{ cm}^{-3}$ , irradiated on its left end with a uniform electron beam having an electron flux of  $10^{19} \text{ cm}^{-2}\text{s}^{-1}$  as illustrated below.\*

As shown, the sample is  $10 \mu\text{m}$  long and has an ohmic contact on its right end; this contact is connected to the electron source to complete the circuit as indicated. In this sample the hole mobility,  $\mu_{h\nu}$  is  $600 \text{ cm}^2/\text{V}\cdot\text{s}$ ; the electron mobility,  $\mu_{e\nu}$  is  $1600 \text{ cm}^2/\text{V}\cdot\text{s}$ ; the electron diffusion length,  $L_{e\nu}$  is  $100 \mu\text{m}$ ; and the intrinsic carrier concentration at room temperature,  $n_i$  is  $10^{10} \text{ cm}^{-3}$ .



- What is the electron current density just inside the bar at the left end, i.e. what is  $J_e(0^+)$ ? Show your work and/or explain your answer.
- Write a formula for  $n'(x)$  in terms of  $n'(0)$  and then determine the value of  $n'(0)$ .

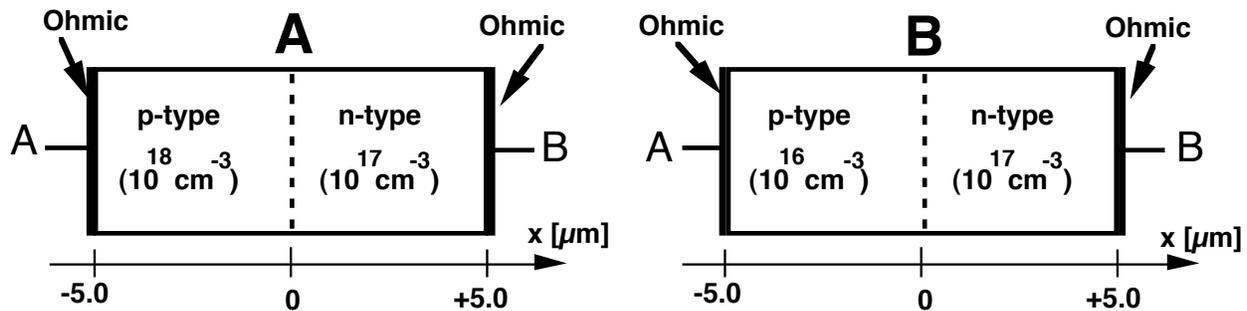
\* In case you are concerned: The electron beam hitting the left end of the bar behaves like an injecting contact. The injected electrons do not have sufficient energy to generate more hole-electron pairs. Also, no holes can leave the left end of the bar.

- (c) Write an expression for the electron current density,  $J_e(x)$ , valid for  $0 < x < 10 \mu\text{m}$ .
- (d) Write an expression for the hole current density,  $J_h(x)$ , valid for  $0 < x < 10 \mu\text{m}$ .
- (e) Write an expression for the electric field,  $E_x(x)$ , valid for  $0 < x < 10 \mu\text{m}$ .
- (f) What is the voltage drop from end to end in this sample? Note: this is the same as the change in electrostatic potential between  $x = 0$  and  $10 \mu\text{m}$ .

**Problem 3** - Do Problem 7.5 in the course text.

**Problem 4** - This problem concerns the two abrupt p-n diodes pictured below. These two diodes have identical dimensions and differ only in the doping levels on the p-sides. In both diodes the n-side is doped with  $10^{17} \text{ cm}^{-3}$  donors. In Diode A the p-side is doped with  $10^{18} \text{ cm}^{-3}$  acceptors and in Diode B it is doped with  $10^{16} \text{ cm}^{-3}$  acceptors. You may assume for purposes of this problem that:

- (1) the widths of the depletion regions on either side of the junctions in these diodes are all negligible relative to  $5 \mu\text{m}$  when they are forward biased,
- (2) the hole mobility is  $600 \text{ cm}^2/\text{V-s}$  and the electron mobility is  $1600 \text{ cm}^2/\text{V-s}$  in all regions, and
- (3) the minority carrier diffusion lengths are much larger than  $10 \mu\text{m}$ .



- a) Which diode has the wider zero-bias depletion region? Explain your answer.
- b) With zero applied bias, in which diode is the magnitude of the peak electric field in the depletion region largest? Explain your answer.
- c) For which diode will the magnitude of the reverse breakdown voltage be largest? Explain your answer.
- d) A reverse bias is applied to both diodes so that the depletion region on the n-side in each diode is  $0.2 \mu\text{m}$  wide.
  - i) What is the width of the depletion region on the p-side in each diode?
  - ii) On which diode is the magnitude of the reverse bias larger? Explain.
- e) A forward bias is applied to each diode so that the excess hole population on the n-side at  $x_n$ ,  $p'(x_n)$ , is  $10^{12} \text{ cm}^{-3}$  in both diodes.
  - i) What are the excess electron populations at the edge of the depletion region on the p-side, i.e.,  $n'(-x_p)$ , in each diode?
  - ii) What is the ratio of the total hole current to the total electron current through each diode at  $x = 0$ ?
  - iii) What is the total excess minority carrier charge per unit area in each diode at this bias level? Note: Consider the entire device, i.e., from  $-5 \mu\text{m}$  to  $+5 \mu\text{m}$ .
  - iv) What is the applied bias on each diode?

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